



FQD5P20 / FQU5P20

200V P-Channel MOSFET

General Description

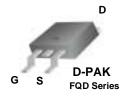
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters.

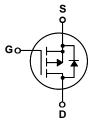
Features

- -3.7A, -200V, $R_{DS(on)} = 1.4\Omega @V_{GS} = -10 V$
- Low gate charge (typical 10 nC)
- Low Crss (typical 12 pF)
- · Fast switching
- 100% avalanche tested
- · RoHS Compliant









Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD5P20 / FQU5P20	Units
V_{DSS}	Drain-Source Voltage		-200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		-3.7	А
			-2.34	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-14.8	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	330	mJ
I _{AR}	Avalanche Current	(Note 1)	-3.7	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C)		45	W
	- Derate above 25°C		0.36	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

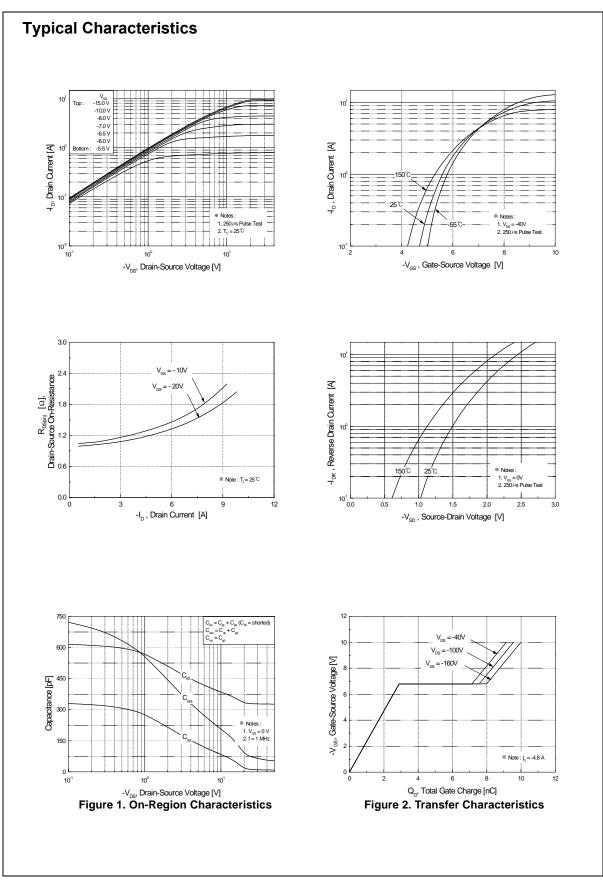
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

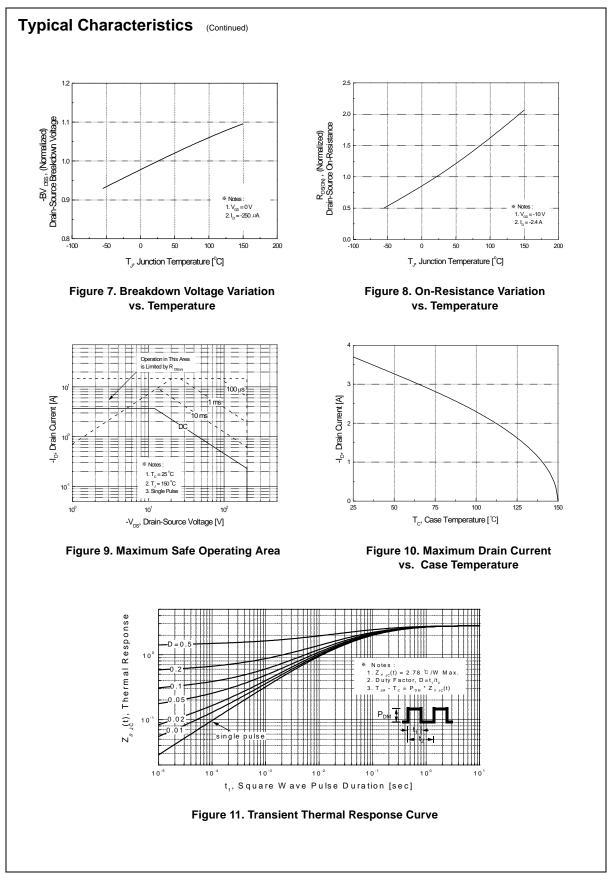
* When mounted on the minimum pad size recommended (PCB Mount)

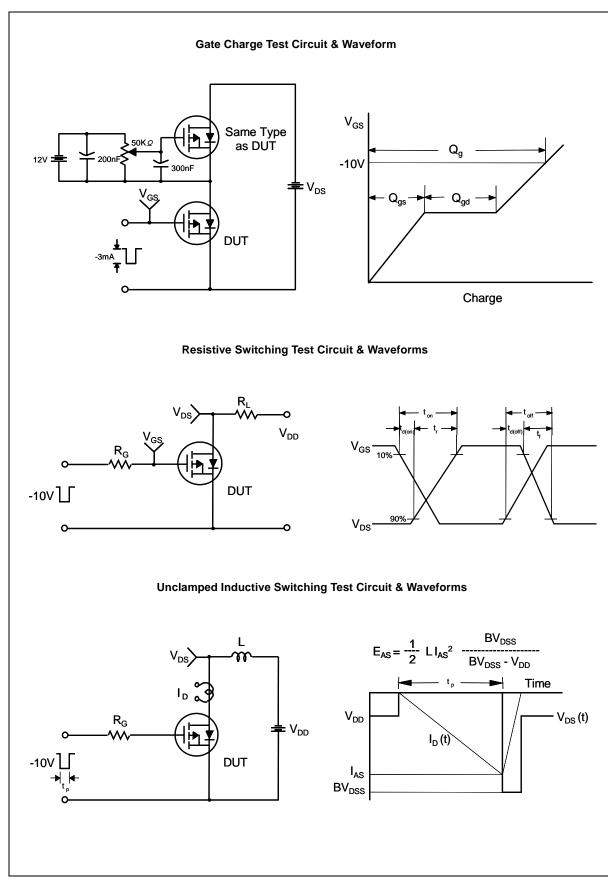
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-200			V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		-0.17		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -200 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -160 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
On Cha	racteristics			1		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10°V, I _D = -1.85 A		1.1	1.4	Ω
g _{FS}	Forward Transconductance	V _{DS} = -40 V, I _D = -1.85 A (Note 4)		2.2		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	 	330 75 12	98 15	pF pF pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = -100 V, I _D = -4.8 A,		9	28	ns
t _r	Turn-On Rise Time	$V_{DD} = -100 \text{ V}, I_D = -4.8 \text{ A},$ $R_G = 25 \Omega$		70	150	ns
t _{d(off)}	Turn-Off Delay Time	1 10 - 20 22		12	35	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		25	60	ns
Qg	Total Gate Charge	V _{DS} = -160 V, I _D = -4.8 A,		10	13	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		2.8		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)	-	5.2		nC
	Source Diode Characteristics a				2.7	Δ.
l _S	Maximum Continuous Drain-Source Diode Forward Current				-3.7	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V, } I_{S} = -3.7 \text{ A}$				-14.8	A
V _{SD}	Drain-Source Diode Forward Voltage			475	-5.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = -4.8 \text{ A},$ $dI_{C} / dt = 100 \text{ A/us} \qquad \text{(Note 4)}$		175		ns
Q_{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		1.07		μC

- 1. Repetitive Rating : Pulse width limited by maximum junction temperat 2. L = 36.2mH, $I_{AS} = -3.7A$, $V_{DD} = -50V$, $R_{G} = 25~\Omega$, Starting $T_{J} = 25^{\circ}C$ 3. $I_{SD} \le -4.8A$, di/dt $\le 300A/\mu_{S}$, $V_{DD} \le BV_{DSS}$, Starting $T_{J} = 25^{\circ}C$ 4. Pulse Test : Pulse width $\le 300\mu_{S}$, Duty cycle $\le 2\%$ 5. Essentially independent of operating temperature

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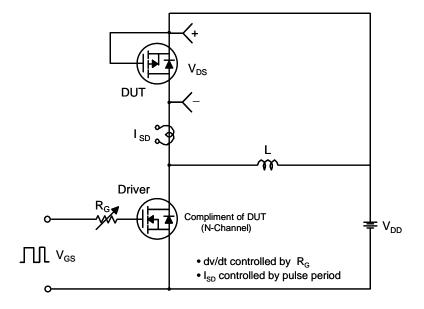


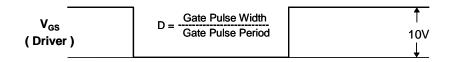




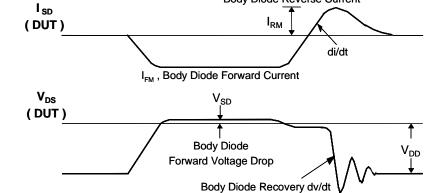
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Peak Diode Recovery dv/dt Test Circuit & Waveforms



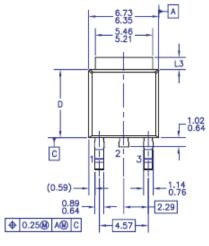


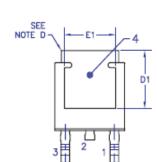
Body Diode Reverse Current

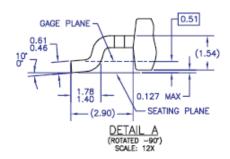


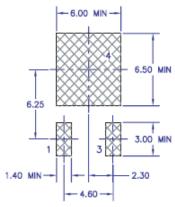
Mechanical Dimensions

D - PAK

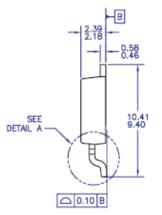




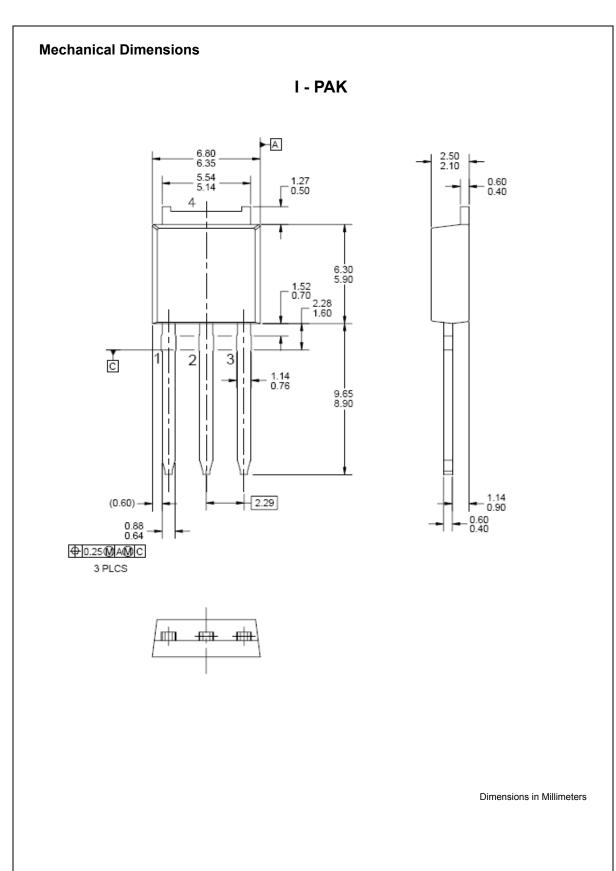




LAND PATTERN RECOMMENDATION



Dimensions in Millimeters







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